

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,692	MATSUMOTO, MARIKO	ARIKO
Examiner	Art Unit	
Frank Duana	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCH (see printout)		4/14/2007	FD		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCH (see printout)	4/24/2007	FD	
INVENTORSHIP SEARCH (see printout)	4/24/07	FD	
IEEE/INTERNET SEARCH (see printout)	4/24/2007	FD	